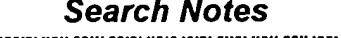


<b>Search Notes</b> 	<b>Application/Control No.</b> 10/019,510	<b>Applicant(s)/Patent under Reexamination</b> KAMMEIJER ET AL.
	<b>Examiner</b> Brian S. Kwon	<b>Art Unit</b> 1614

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
574	365	10/10/57	G